

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BEMENT ET AL.	
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		Craig A. Renner	2652	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-		-	
	C	US-			
	D	US-			
	E	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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